

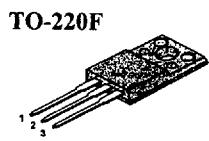
Advanced Power MOSFET

SSS10N60A

FEATURES

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 25 μ A (Max.) @ $V_{DS} = 600V$
- Low $R_{DS(ON)}$: 0.646 Ω (Typ.)

$BV_{DSS} = 600 V$
 $R_{DS(on)} = 0.8 \Omega$
 $I_D = 5.1 A$



1.Gate 2. Drain 3. Source

Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
V_{DSS}	Drain-to-Source Voltage	600	V
I_D	Continuous Drain Current ($T_c=25^\circ C$)	5.1	A
	Continuous Drain Current ($T_c=100^\circ C$)	3.2	
I_{DM}	Drain Current-Pulsed ①	36	A
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy ②	709	mJ
I_{AR}	Avalanche Current ①	5.1	A
E_{AR}	Repetitive Avalanche Energy ①	5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	3.0	V/ns
P_D	Total Power Dissipation ($T_c=25^\circ C$)	50	W
	Linear Derating Factor	0.4	$W/\text{ }^\circ C$
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ C$
	Maximum Lead Temp. for Soldering Purposes, 1/8 " from case for 5-seconds	300	

Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	2.5	$^\circ C/W$
	Junction-to-Ambient	--	62.5	

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Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
BV_{DSS}	Drain-Source Breakdown Voltage	600	--	--	V	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$
$\Delta \text{BV}/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	0.66	--	V/ $^\circ\text{C}$	$\text{I}_D=250\mu\text{A}$ See Fig 7
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	--	4.0	V	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=250\mu\text{A}$
I_{GSS}	Gate-Source Leakage, Forward	--	--	100	nA	$\text{V}_{\text{GS}}=30\text{V}$
	Gate-Source Leakage, Reverse	--	--	-100	nA	$\text{V}_{\text{GS}}=-30\text{V}$
I_{DSS}	Drain-to-Source Leakage Current	--	--	25	μA	$\text{V}_{\text{DS}}=600\text{V}$
		--	--	250	μA	$\text{V}_{\text{DS}}=480\text{V}, \text{T}_c=125^\circ\text{C}$
$\text{R}_{\text{DS(on)}}$	Static Drain-Source On-State Resistance	--	--	0.8	Ω	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=2.55\text{A}$ ④
g_{fs}	Forward Transconductance	--	6.23	--	mS	$\text{V}_{\text{DS}}=50\text{V}, \text{I}_D=2.55\text{A}$ ④
C_{iss}	Input Capacitance	--	1750	2270	pF	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=25\text{V}, f=1\text{MHz}$ See Fig 5
C_{oss}	Output Capacitance	--	190	220	pF	
C_{rss}	Reverse Transfer Capacitance	--	78	90	pF	
$t_{\text{d(on)}}$	Turn-On Delay Time	--	20	50	ns	$\text{V}_{\text{DD}}=300\text{V}, \text{I}_D=10\text{A},$ $\text{R}_G=6.2\Omega$ See Fig 13 ④⑤
t_r	Rise Time	--	23	55	ns	
$t_{\text{d(off)}}$	Turn-Off Delay Time	--	85	180	ns	
t_f	Fall Time	--	30	70	ns	
Q_g	Total Gate Charge	--	74	95	nC	$\text{V}_{\text{DS}}=480\text{V}, \text{V}_{\text{GS}}=10\text{V},$ $\text{I}_D=10\text{A}$
Q_{gs}	Gate-Source Charge	--	12	--	nC	See Fig 6 & Fig 12 ④⑤
Q_{gd}	Gate-Drain("Miller") Charge	--	35.4	--	nC	

Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
I_S	Continuous Source Current	--	--	5.1	A	Integral reverse pn-diode in the MOSFET
I_{SM}	Pulsed-Source Current ①	--	--	36	A	
V_{SD}	Diode Forward Voltage ④	--	--	1.4	V	$\text{T}_J=25^\circ\text{C}, \text{I}_S=5.1\text{A}, \text{V}_{\text{GS}}=0\text{V}$
t_{rr}	Reverse Recovery Time	--	440	--	ns	$\text{T}_J=25^\circ\text{C}, \text{I}_F=10\text{A}$
Q_{rr}	Reverse Recovery Charge	--	4.7	--	μC	$d\text{i}/dt=100\text{A}/\mu\text{s}$ ④

Notes :

① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature

② $L=50\text{mH}, \text{I}_{\text{AS}}=5.1\text{A}, \text{V}_{\text{DD}}=50\text{V}, \text{R}_G=27\Omega$, Starting $\text{T}_J=25^\circ\text{C}$

③ $\text{I}_{\text{SD}} \leq 10\text{A}, d\text{i}/dt \leq 50\text{A}/\mu\text{s}, \text{V}_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, Starting $\text{T}_J=25^\circ\text{C}$

④ Pulse Test : Pulse Width = $250\mu\text{s}$, Duty Cycle $\leq 2\%$

⑤ Essentially Independent of Operating Temperature

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Fig 1. Output Characteristics

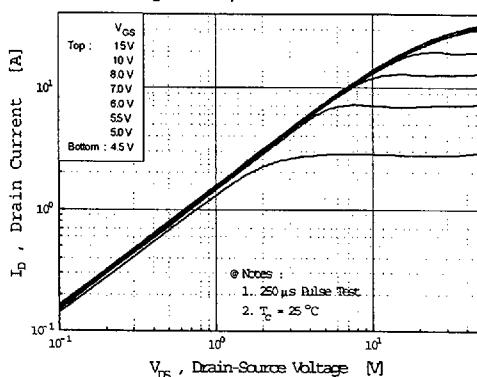


Fig 2. Transfer Characteristics

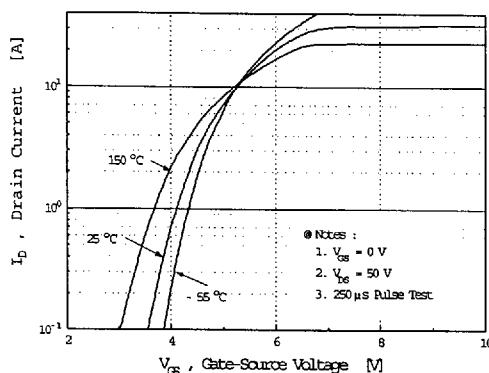


Fig 3. On-Resistance vs. Drain Current

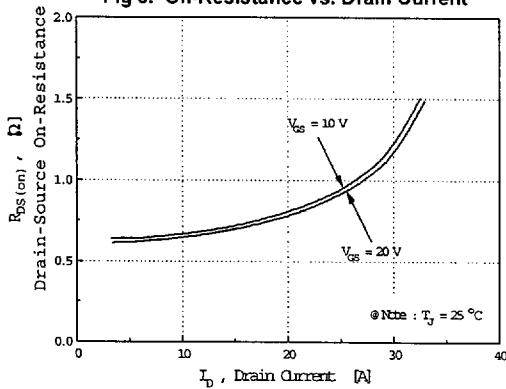


Fig 4. Source-Drain Diode Forward Voltage

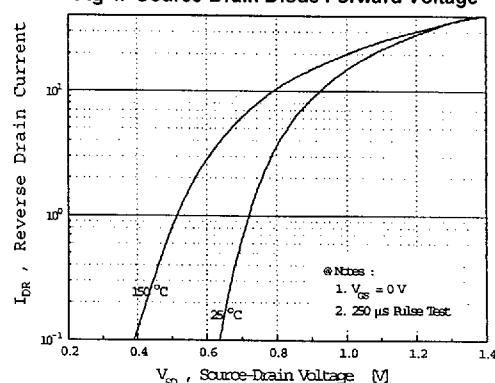


Fig 5. Capacitance vs. Drain-Source Voltage

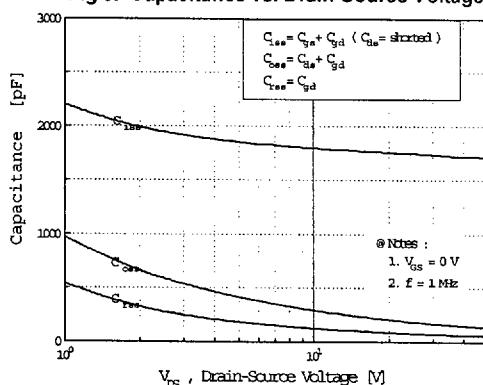
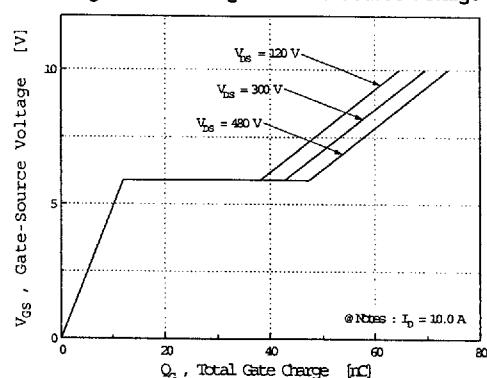
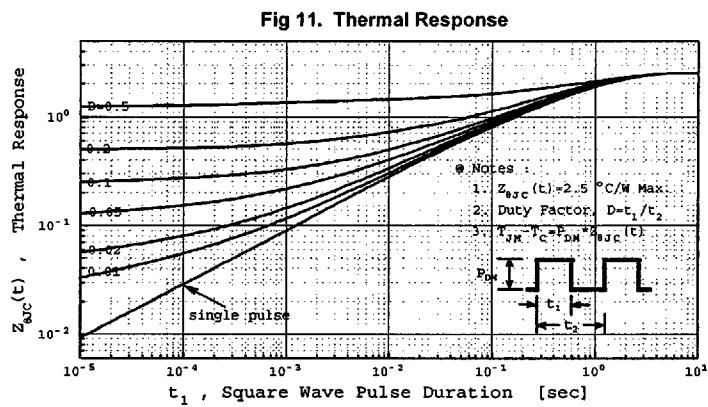
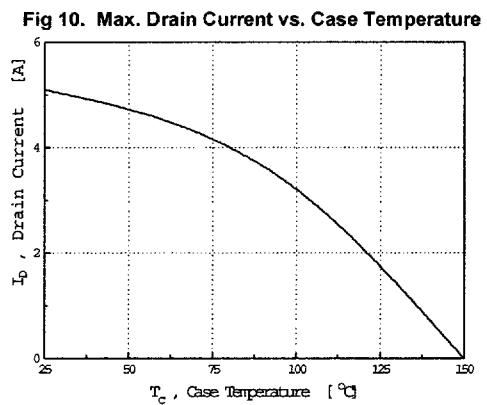
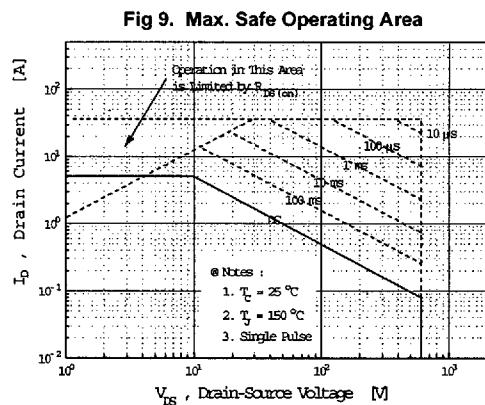
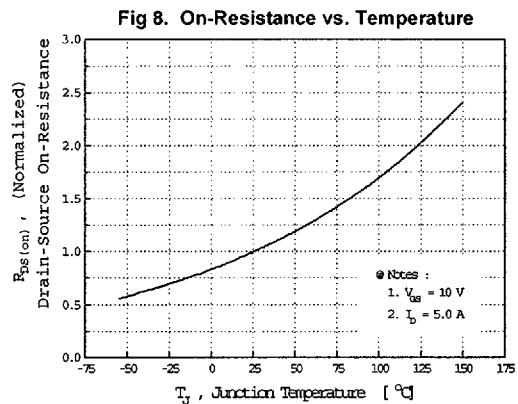
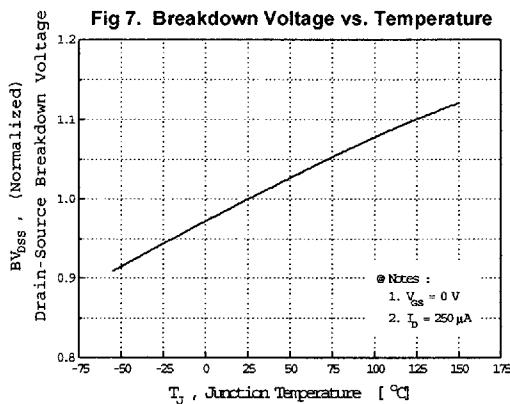


Fig 6. Gate Charge vs. Gate-Source Voltage



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Fig 12. Gate Charge Test Circuit & Waveform

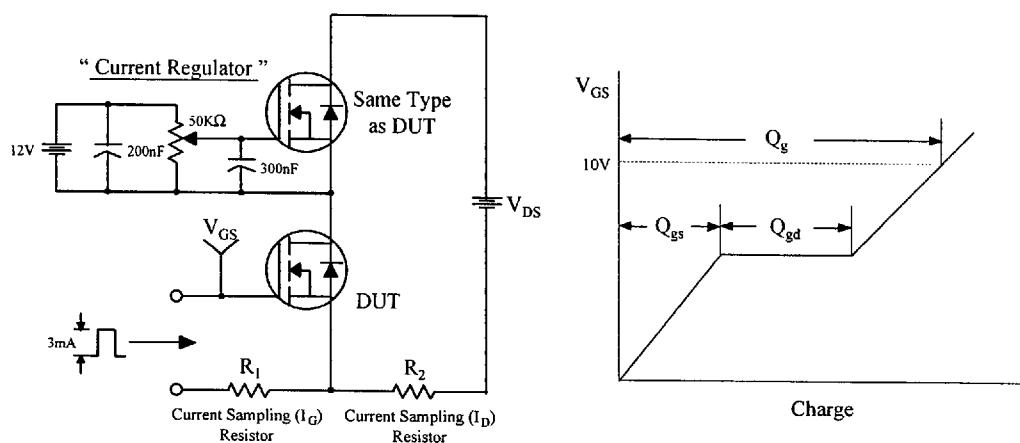


Fig 13. Resistive Switching Test Circuit & Waveforms

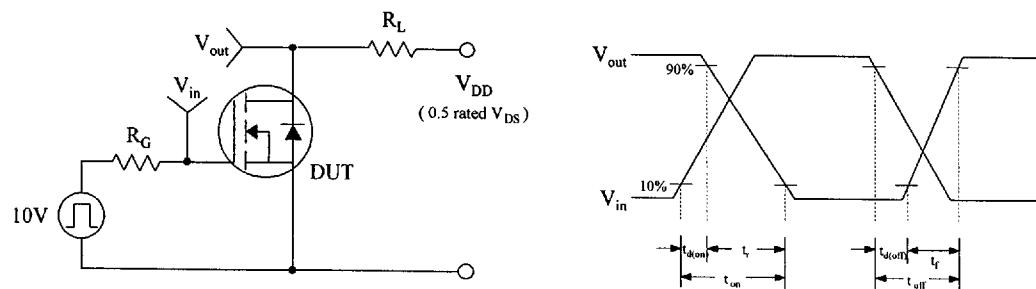
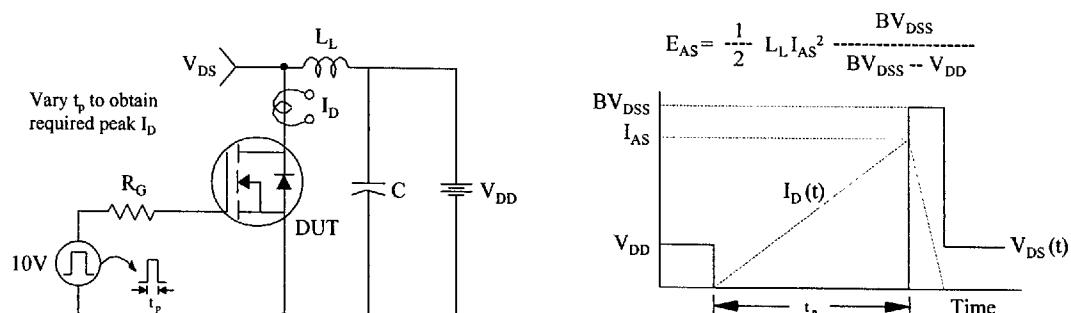


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms



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Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

